

| Search Notes  | Application/Control No.                         | Applicant(s)/Patent under Reexamination |
|---|---|---|
|  | 09/927,909                                      | CWIK ET AL.                             |
|   | Examiner<br>Kevin P. Kerns<br>Kevin L. Mettenay | Art Unit<br>1725                        |

| INTERFERENCE SEARCHED |   |         |          |
|-----------------------|---|---------|----------|
| Class                 | Subclass                                      | Date    | Examiner |
| 422                   | 220, 221,<br>224, 191                         | 9/17/05 | KPK      |
| 159                   | 43.1, 44,<br>17.2, 28.6,<br>Dig. 8<br>Dig. 28 |         |          |
|                       |   |         |          |